## Western Digital.

Open Composable Compatibility Lab 9960 Federal Drive Colorado Springs CO 80920

> Info@OpenComposable.com www.OpenComposable.com



## **Open Composable Compatibility**

Fabric Interoperability demonstrated with other fabric attached devices

OCCL Individual Device Verification Chart

				RoCE Loss	ess Testing	ţ	Test Topology					
			Global Pause	Priority Flow Control	Explicit Congestion Notification	PFC + ECN	Single Path Single Switch	Dual Path Single Switch	single Path Routed	Dual Path Routed		
	Vendor	Model	Glo	Pri	Ĕ	ΡF	Sin	Du	Si J	Du		
	Western Digital OpenFlex	F3000		•	•	•	•					
Flash Storage	Western Digital OpenFlex	F3100		•	•	•	•					
	Western Digital OpenFlex	F3200		•	•	•	•					
	Mellanox	CX-5		•	•	•	•	•	•	•		
	Mellanox	CX-6		٠	•	•	•	•	•	•		
RNIC	Mellanox	CX-6DX										
	Mellanox	Bluefield		•								
	Broadcom	P1100p		•	•	•	•	•	•	•		
	Broadcom	P2100G		•	•	•	•					
	Mellanox	SN2100 Onyx		٠	•	•	•	•	•	•		
Switch	Arista	7050CX3		٠	•	•	•					
	Arista	7280		•	•	•	•					

Last Update: December 2020 Next Update Due: March 2021

Note:

• This chart is a high level summary of the individual devices RoCE compatibility testing to date.

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## OCCL Device Test Matrix

ID	S	erve	er			RN	NIC			Switch Fabric			Fabric Device				Test Date	Lossloss Tosting				Tanalami			
U	OS		Mellanox			Bro	Broadcom		Mellanox	x Arista		Potomac		Kazan	B Box	Test Date	Lossless Testing				Тороlоду				
	Ubuntu 20.04	CentOS 7.6	CentOS 8.1	CK-5	CX-6	Bluefield	P1100P	P2Z5P	P2100G	SN2100 Опук	7050CX3	7280	Western Digital F3100	Western Digital F3200	Western Digital Onyx	OCCL Test Box	CY 2020	Global Pause	PFC	ECN	PFC + ECN	Single Path Single Switch	Dual Path Single Switch	Single Path Routed	Dual Path Routed
1		٠		٠						•			٠				2-Mar-20		•	•	•	•	•	•	•
1.5		٠				•				•			٠				2-Mar-20		•						
1.1		٠					•			•			٠				24-Feb-20		•	•	•	•			
1.11		٠		٠							•		٠				9-Mar-20		•	•	•	•			
1.13		٠		٠						•				•			16-Mar-20		•	•	•	•			
2			٠	٠						•						•	2-Jun-20		•	•	•	•			
2.1			٠		•					•						•	8-Jul-20		•	•	•	•	•	•	•
2.2			٠				•			•						•	24-Jun-20		•	•	•	•	•	•	•
2.3			٠						•	•						•	25-Jun-20		•	•	•	•			
2.6			٠	٠								•				•	15-Aug-20		•	•	•	•			
2.7			٠	٠						•					•		30-Sep-20		•	•	•	•			
3	٠			٠						•						•	3-Dec-20		•	•	•	•	•		

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Note:

- This matrix is a high level summary of compatibility testing to date.
- Detailed reports for each test ID can be requested via <a href="https://www.info@OpenComposable.com">Info@OpenComposable.com</a>

Baselines:

- A baseline (ID 1, 2 etc.) consists of a set of known good candidate devices.
- As a rule, only one aspect (yellow dot) of the established baseline can modified at a time.
- A modified baseline will become a sub-baseline of the original baseline (1.5, 2.1 etc.).

To prevent baselines from becoming outdated and to allow for the timely and controlled submission of new / updated candidate devices, the OCCL generally states 6 months between tests. The OCCL publishes detailed guidelines on test procedure, baseline maintenance and change control via <u>www.OpenComposable.com</u>

Any requests for compatibility testing can be submitted via Info@OpenComposable.com